





REF35 SNAS809B - DECEMBER 2021 - REVISED MAY 2024

REF35 Ultra Low-Power, High-Precision Voltage Reference

1 Features

- Ultra-low quiescent current:
 - 650nA (typical)
- Initial accuracy: ±0.05% (maximum)
- Temperature coefficient (maximum):
 - 12ppm/°C (-40°C to 105°C, SOT23 package)
 - 10ppm/°C (-40°C to 85°C, WCSP package)
- Output 1/f noise (0.1Hz to 10Hz): 3.3ppm_{P-P}
- NR pin to reduce noise
- EN pin to reduce shutdown current consumption
- Long-term stability: 40ppm at 1k hour
- Thermal hysteresis: 70ppm
- Operating temperature range: -55°C to +125°C
- Output current: +10mA, -5mA
- Input voltage: V_{REF} + V_{DO} to 6V
- Output voltage options:
 - 1.024V, 1.2V, 1.25V, 1.6V, 1.8V, 2.048V, 2.5V, 3.0V, 3.3V, 4.096V, 5.0V
- Small footprint 6-pin SOT-23 package
- Smallest footprint 4-pin WCSP package

2 Applications

- Flow transmitter
- Blood glucose monitor
- Servo drive control module
- Power quality analyzer
- Fault indicator
- Oscilloscope
- **Process analytics**
- **Optical Module**

3 Description

The REF35 is a family of nanopower, low-drift, highprecision series reference devices. The REF35 family features ±0.05% initial accuracy with 650nA typical power consumption. The temperature coefficient (12ppm/°C) and long-term stability (40ppm at 1000 hours) of the device can help improve system stability and reliability. The low power consumption combined with high precision specifications are designed for a wide variety of portable and low current applications.

The REF35 supplies up to 10mA current with 3.3ppm_{p-p} noise and 20ppm/mA load regulation. With this feature set, REF35 creates a strong low-noise, high accuracy power supply for precision sensors and 12-16b data converters.

The family is specified for operation from -40°C to 105°C and is functional over -55°C to 125°C. The wide temperature is suited for industrial applications.

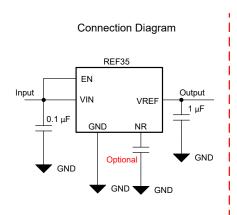
REF35 is available in wide output voltage variants starting from 1.024V to 5.0V. The device is offered in a space-saving, 6-pin SOT-23 and 4-pin WCSP package options. Contact your local TI sales representative for available voltage and package options.

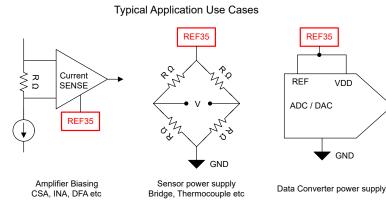
Package Information

| PART NUMBER | PACKAGE (1) | BODY SIZE (NOM) (2) | | |
|-------------|-------------|---------------------|--|--|
| REF35xxx | SOT-23 (6) | 2.90mm × 1.60mm | | |
| KEL99XXX | WCSP (4) | 1.05mm × 0.84mm | | |

- For all available voltage variants and packages, see the orderable addendum at the end of the data sheet.
- The package size (length × width) is a nominal value and includes pins, where applicable.

GND





REF35 Use Case



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4 Device Comparison

| PRO | DUCT | V |
|---------------|--------------|------------------|
| SOT-23 (6) | WCSP (4) | V _{REF} |
| REF35102QDBVR | REF35102YBHR | 1.024V |
| REF35120QDBVR | REF35120YBHR | 1.2V |
| REF35125QDBVR | REF35125YBHR | 1.25V |
| REF35160QDBVR | REF35160YBHR | 1.6V |
| REF35170QDBVR | - | 1.7V |
| REF35180QDBVR | REF35180YBHR | 1.8V |
| REF35205QDBVR | - | 2.048V |
| REF35250QDBVR | REF35250YBHR | 2.5V |
| REF35300QDBVR | REF35300YBHR | 3.0V |
| REF35330QDBVR | - | 3.3V |
| REF35360QDBVR | - | 3.6V |
| REF35409QDBVR | REF35409YBHR | 4.096V |
| REF35500QDBVR | - | 5.0V |

5 Pin Configuration and Functions

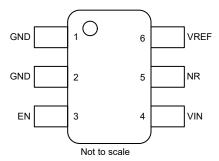


Figure 5-1. DBV Package 6-Pin SOT-23 Top View

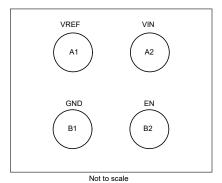


Figure 5-2. YBH Package 4-Pin WCSP Top View

Table 5-1. Pin Functions

| | PIN | | TYPE | DESCRIPTION | | | | | |
|------|--------|------|----------------------------------|--|--|--|--|--|--|
| NAME | SOT-23 | WCSP | ITPE | DESCRIPTION | | | | | |
| GND | 1 | B1 | Ground | Device ground connection. For DBV package pin 1 and pin 2 are internally short. | | | | | |
| GND | 2 | - | Ground Device ground connection. | | | | | | |
| EN | 3 | B2 | Input | Enable connection. Enables or disables the device. | | | | | |
| VIN | 4 | A2 | Power | Input supply voltage connection. | | | | | |
| NR | 5 | - | Output | Noise reduction pin. Connect a capacitor to reduce noise. This pin can be left floating. | | | | | |
| VREF | 6 | A1 | Output | Reference voltage output. | | | | | |



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

| | | MIN | MAX | UNIT |
|------------------------------|------------------|------|-------------------------|------|
| Input voltage | IN | -0.3 | 6.5 | V |
| Enable voltage | EN | -0.3 | IN + 0.3 ⁽²⁾ | V |
| Output voltage | V_{REF} | -0.3 | IN + 0.3 ⁽²⁾ | V |
| Output short circuit current | I _{SC} | | 20 | mA |
| Operating temperature range | T _A | -55 | 125 | °C |
| Storage temperature range | T _{stg} | -65 | 170 | °C |

⁽¹⁾ Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

6.2 ESD Ratings

| | | | VALUE | UNIT |
|--------|-------------------------|---|-------|------|
| V | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾ | ±2000 | V |
| V(ESD) | Electrostatic discharge | Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002, all pins (2) | ±750 | V |

¹⁾ JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | J , | | | |
|----------------|-----------------------|---|-------|---------|
| | | MIN | NOM M | AX UNIT |
| IN | Input voltage (1) | V _{OUT} + V _{DO} ⁽²⁾ | | 6 V |
| EN | Enable voltage | 0 | | IN V |
| IL | Output current | -5 | | 10 mA |
| T _A | Operating temperature | -40 | 25 1 | 25 °C |

⁽¹⁾ For $V_{REF} = 1.024V$ to 1.5V, minimum $V_{IN} = 1.7V$

6.4 Thermal Information

| | | RE | | |
|-----------------------|--|------------|--------------|------|
| | THERMAL METRIC ⁽¹⁾ | YBH (WCSP) | DBV (SOT-23) | UNIT |
| | | 4 PINS | 6 PINS | |
| R _{θJA} | Junction-to-ambient thermal resistance | 178.9 | 164.4 | °C/W |
| R _{0JC(top)} | Junction-to-case (top) thermal resistance | 1.1 | 102.5 | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 60.3 | 59.6 | °C/W |
| Ψ_{JT} | Junction-to-top characterization parameter | 0.5 | 44.0 | °C/W |
| Ψ_{JB} | Junction-to-board characterization parameter | 60.2 | 59.4 | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | N/A | N/A | °C/W |

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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⁽²⁾ IN + 0.3V or 6.5V, whichever is lower

⁽²⁾ JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

⁽²⁾ V_{DO} = Dropout voltage



6.5 Electrical Characteristics

At $V_{IN} = V_{REF} + 0.5V$, $V_{EN} = V_{IN}$, $C_L = 10\mu F$, $C_{IN} = 0.1\mu F$, $I_L = 0 mA$, minimum and maximum specifications at $T_A = -40 ^{\circ} C$ to 125°C, typical specifications $T_A = 25 ^{\circ} C$; unless otherwise noted

| | PARAMETER | TEST | CONDITION | MIN | TYP | MAX | UNIT |
|------------------------------------|--|---|---|------------------------------------|------|-----------------------|--------------------|
| ACCURAC | Y AND DRIFT | | | | | | |
| | Output voltage accuracy | T _A = 25°C | | -0.05 | | 0.05 | % |
| | Output voltage temperature coefficient | -40°C ≤ T _A ≤ 105°C | | | | 12 | ppm/°C |
| LINE AND | LOAD REGULATION | | | | | | |
| | $V_{OFF} \le 2.5 \text{ V} \cdot \text{V}_{OFF} + V_{OFF} + V_{OFF} + 0.00 \text{ to } \text{V}_{OFF} = 40^{\circ}\text{C} \le 1.00 \text{ to } \text{V}_{OFF} = $ | | | | | | |
| ΔV _{REF} / | Line regulation | $T_A \le 105^{\circ}C$ | REF . VDO to VINMAX, 40 0 = | | 40 | 160 | ppm/V |
| ΔV_{IN} | Line regulation | $V_{REF} \ge 2.5V$; $V_{IN} = V_{F}$ $T_{A} \le 105$ °C | $_{REF}$ + V_{DO} to V_{INMAX} ; $-40^{\circ}C \le$ | | 40 | 120 | ppm/V |
| $\Delta V_{REF}/\Delta I_{L}$ | | I_L = 0mA to 10mA, V_{IN} = V_{REF} + V_{DO} | Source | | 20 | 60 | ppm/mA |
| ΔV _{REF} /ΔI _L | Load regulation | $I_L = 0$ mA to 5mA, $V_{IN} = V_{REF} + V_{DO}$ | Sink | | 40 | 350 | ppm/mA |
| POWER S | UPPLY | | | | | l | |
| V _{IN} | Input voltage (1) | | | V _{REF} + V _{DO} | | 6 | V |
| | | | T _A = 25°C | | 0.65 | 0.9 | |
| | | Active mode | -40°C ≤ T _A ≤ 85°C | | | 1.3 | |
| IQ | Quiescent current | | -40°C ≤ T _A ≤ 125°C | | | 2.6 | μΑ |
| u . | | | T _A = 25°C | | | 0.1 | • |
| | | Shutdown mode | -40°C ≤ T _A ≤ 125°C | | | 0.5 | |
| ., | Facility at a continuous | Active mode (EN = 1 | or Float) | 0.7 x V _{IN} | | | |
| V _{EN} | Enable pin voltage | Shutdown mode (EN | = 0) | | | 0.3 x V _{IN} | V |
| I _{EN} | Enable pin current | V _{EN} = V _{IN} | | | 0.05 | 0.1 | uA |
| | I _L = 5mA | | | | | 120 | \/ |
| V_{DO} | Dropout voltage | I _L = 10mA | | | | 250 | mV |
| I _{sc} | Short circuit current, Sourcing | V _{REF} = 0V, T _A = 25°C | ; | | 33 | | mA |
| I _{SC} | Short circuit current, Sinking | V _{REF} = V _{IN} V, T _A = 25 | 5°C | | 21 | | mA |
| TURN-ON | TIME | 1 | | | | | |
| t _{ON} | Turn-on time (2) | 0.1% settling, C _L = 1 | uF, V _{REF} = 2.5V | | 2 | | ms |
| NOISE | | | | | | l | |
| e _n | Output voltage noise | $f = 10$ Hz to 1kHz, C_L | _= 1µF | | 0.7 | | ppm _{rms} |
| _ | 1 • | f = 0.1Hz to 10Hz, V | _{REF} ≥ 2.5V | | 3.8 | | ppm _{p-p} |
| e _{np-p} | Low-frequency noise | f = 0.1Hz to 10Hz, V | _{REF} < 2.5V | | 3.3 | | ppm _{p-p} |
| HYSTERE | SIS AND LONG-TERM ST | ABILITY | | | | ' | |
| | Long-term stability | 0 to 1000h at 35°C | | | 40 | | ppm |
| | Output voltage hysteresis | 25°C, –40°C, 105°C, | 25°C (cycle 1) | | 70 | | ppm |
| | Output voltage hysteresis | 25°C, -40°C, 105°C, | 25°C (cycle 2) | | 20 | | ppm |
| | Output voltage hysteresis | 25°C, -40°C, 85°C, 2 | 25°C (cycle 1) | | 50 | | ppm |
| | | 25°C, –40°C, 85°C, 25°C (cycle 1) | | | | | |



6.5 Electrical Characteristics (continued)

At V_{IN} = V_{REF} + 0.5V, V_{EN} = V_{IN} , C_L = 10 μ F, C_{IN} = 0.1 μ F, I_L = 0mA, minimum and maximum specifications at T_A = -40°C to 125°C, typical specifications T_A = 25°C; unless otherwise noted

| PARAMETER | | TEST CONDITION | MIN | TYP M | ٩X | UNIT |
|-----------|---|----------------|-----|-------|----|------|
| In | nput capacitor range | | 0.1 | | | μF |
| | Output capacitor ange ⁽³⁾ | | 0.1 | | 10 | μF |

- (1) For V_{REF} = 1.024V to 1.5V, minimum V_{IN} = 1.7V
- (2) Scales linearly with V_{REF}.
 (3) ESR for the capacitor <= 400mΩ

6.6 Electrical Characteristics YBH package

At V_{IN} = V_{REF} + 0.5V, V_{EN} = V_{IN} , C_{REF} = 10 μ F, C_{IN} = 0.1 μ F, I_L = 0mA, minimum and maximum specifications at T_A = -40° C to 125 $^{\circ}$ C, typical specifications T_A = 25 $^{\circ}$ C; unless otherwise noted

| , ., ., ., | PARAMETER | TEST C | ONDITION | MIN | TYP | MAX | UNIT |
|-------------------------------|--|---|---|------------------------------------|------|---------------------|--------------------|
| ACCURAC | Y AND DRIFT | | | | | | |
| | Output voltage accuracy | T _A = 25°C | | -0.05 | | 0.05 | % |
| | Output voltage temperature coefficient | -40°C ≤ T _A ≤ 85°C | | | | 10 | ppm/°C |
| LINE AND | LOAD REGULATION | | | | | | |
| ΔV _{REF} / | Line regulation | V_{REF} < 2.5V; V_{IN} = V_{RE} | + V _{DO} to V _{INMAX} | | 40 | 160 | ppm/V |
| ΔV_{IN} | Line regulation | V _{REF} ≥ 2.5V; V _{IN} = V _{REI} | + V _{DO} to V _{INMAX} | | 40 | 80 | ppm/V |
| ۸۱/ /۸۱ | Load regulation | I_L = 0mA to 10mA, V_{IN} = V_{REF} + V_{DO} | Source | | 20 | 60 | ppm/mA |
| $\Delta V_{REF}/\Delta I_{L}$ | Load regulation | I_L = 0mA to 5mA, V_{IN} = V_{REF} + V_{DO} | Sink | | 40 | 350 | ppm/mA |
| POWER SI | JPPLY | | | | | | |
| V _{IN} | Input voltage (1) | | | V _{REF} + V _{DO} | | 6 | V |
| | Quiescent current | | T _A = 25°C | | 0.65 | 0.9 | |
| | | Active mode nt current | -40°C ≤ T _A ≤ 85°C | | | 1.3 | |
| I_Q | | | –40°C ≤ T _A ≤ 125°C | | | 2.6 | μΑ |
| | | Shutdown mode | T _A = 25°C | | | 0.1 | |
| | | Silutuowii iiloue | -40°C ≤ T _A ≤ 125°C | | | 0.5 | |
| V _{EN} | Enable pin voltage | Active mode (EN = 1 or | Float) | 0.7 x V _{IN} | | | V |
| VEN | Lilable pili voltage | Shutdown mode (EN = | 0) | | | $0.3 \times V_{IN}$ | V |
| I_{EN} | Enable pin current | $V_{EN} = V_{IN}$ | | | 0.05 | 0.1 | uA |
| V_{DO} | Dropout voltage | I _L = 5mA | | | | 120 | mV |
| v DO | Dropout voltage | I _L = 10mA | | | | 250 | 111.0 |
| I _{SC} | Short circuit current, Sourcing | V _{REF} = 0V, T _A = 25°C | | | 30 | | mA |
| I _{sc} | Short circuit current, Sinking | $V_{REF} = V_{IN} V$, $T_A = 25^{\circ}C$ | ; | | 20 | | mA |
| TURNON T | IME | | | | | | |
| t _{ON} | Turn-on time (2) | 0.1% settling, C _{REF} = 1 | uF, V _{REF} = 2.048V | | 2 | | ms |
| NOISE | | | | | | | |
| e _n | Output voltage noise | f = 10Hz to 1kHz | | | 0.7 | | ppm _{rms} |
| | Low frequency noise | f = 0.1Hz to 10Hz, V_{RE} | _F ≥ 2.5V | | 3.8 | | ppm _{p-p} |
| e _{np-p} | Low frequency floise | $f = 0.1$ Hz to 10Hz, V_{RE} | _F < 2.5V | | 3.3 | | ppm _{p-p} |
| HYSTERES | SIS AND LONG-TERM ST | ABILITY | | | | | |

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6.6 Electrical Characteristics YBH package (continued)

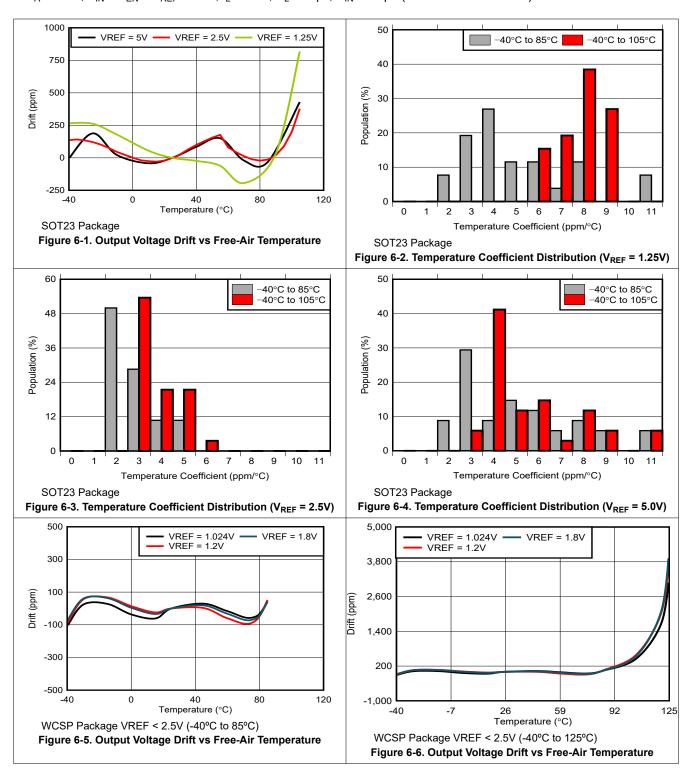
At V_{IN} = V_{REF} + 0.5V, V_{EN} = V_{IN} , C_{REF} = 10 μ F, C_{IN} = 0.1 μ F, I_L = 0mA, minimum and maximum specifications at T_A = -40° C to 125 $^{\circ}$ C, typical specifications T_A = 25 $^{\circ}$ C; unless otherwise noted

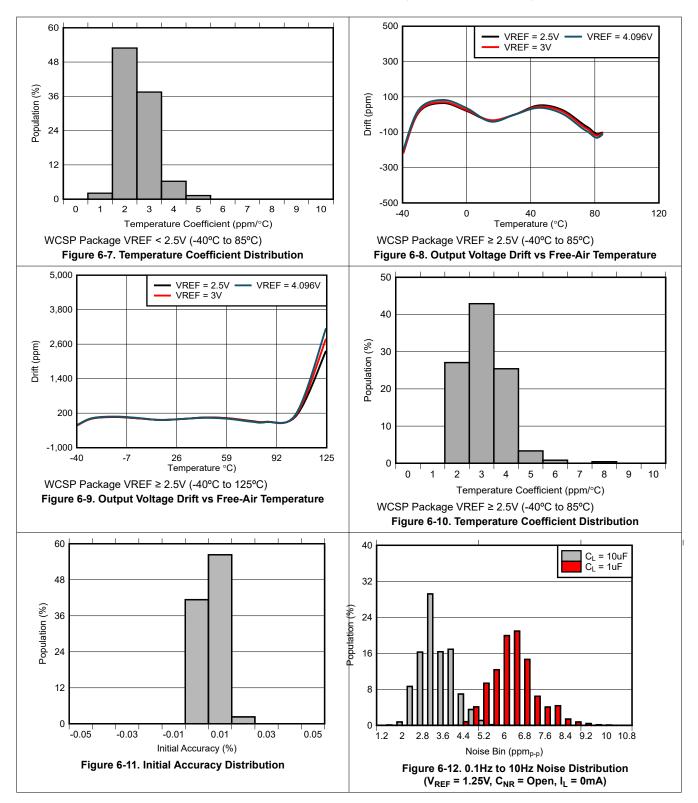
| 120 C, typical openications 1 _A 20 C, almost earlier times herea | | | | | | |
|---|---------------------------|------------------------------------|-----|-----|-----|------|
| | PARAMETER | TEST CONDITION | MIN | TYP | MAX | UNIT |
| | Long-term stability | 0 to 1000h at 35°C | | 40 | | ppm |
| | Output voltage hysteresis | 25°C, -40°C, 125°C, 25°C (cycle 1) | | 70 | | ppm |
| STABLE C | APACITANCE RANGE | | | | | |
| | Input capacitor range | | 0.1 | | | μF |
| | Output capacitor range | | 0.1 | | 10 | μF |

 $[\]begin{array}{ll} \text{(1)} & \text{For V}_{\text{REF}} = 1.024 \text{V to 1.5V, minimum V}_{\text{IN}} = 1.7 \text{V}. \\ \text{(2)} & \text{Scales linearly with V}_{\text{REF}}. \\ \text{(3)} & \text{ESR for the capacitor can range from } 10 \text{m}\Omega \text{ to } 400 \text{m}\Omega. \\ \end{array}$

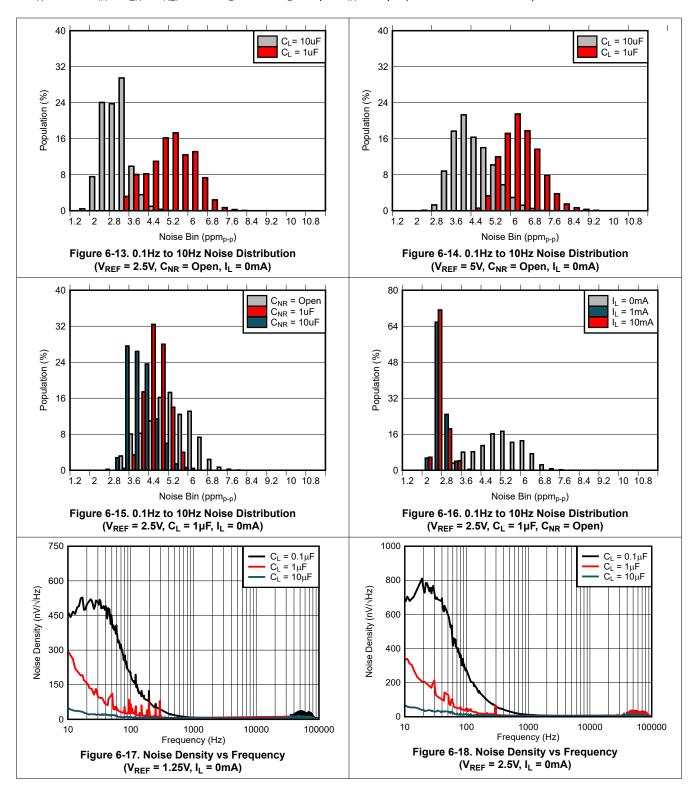


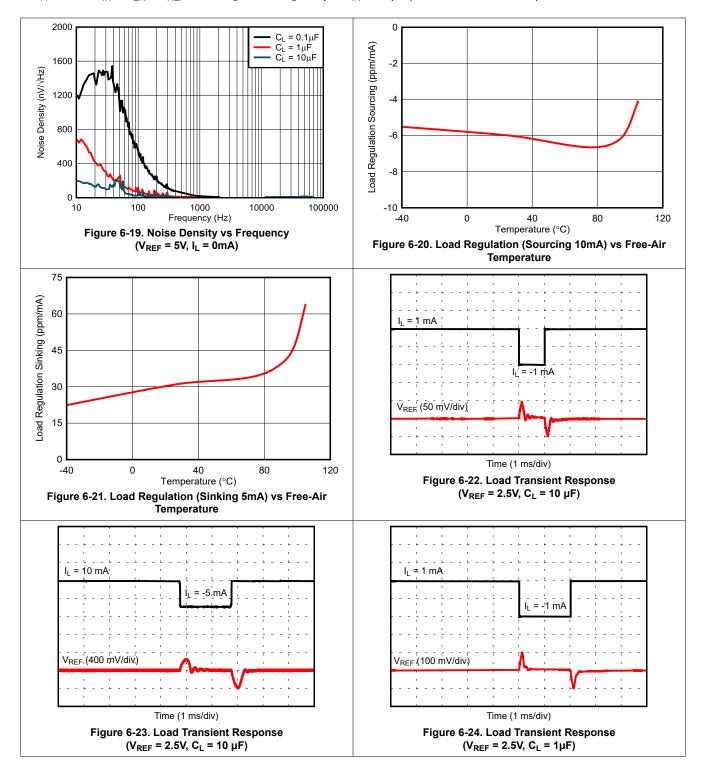
6.7 Typical Characteristics



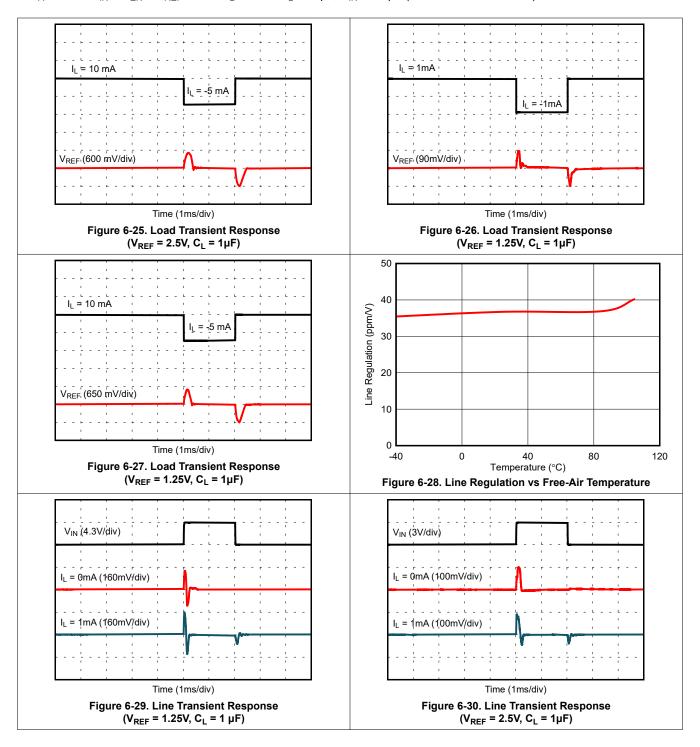


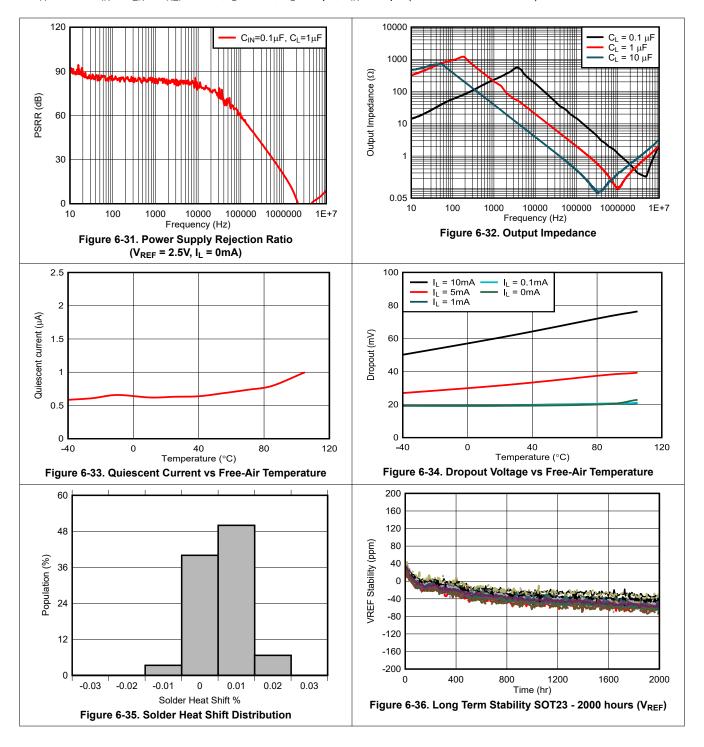




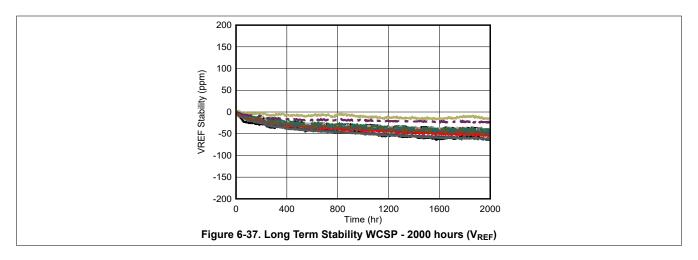












7 Parameter Measurement Information

7.1 Solder Heat Shift

The materials used in the manufacture of the REF35 have differing coefficients of thermal expansion, resulting in stress on the device die when the part is heated. Mechanical and thermal stress on the device die can cause the output voltages to shift, degrading the initial accuracy specifications of the product. Reflow soldering is a common cause of this error.

To illustrate this effect, a total of 32 devices were soldered on one printed circuit board using lead-free solder paste and the paste manufacturer suggested reflow profile. Figure 7-1 shows the reflow profile. The printed circuit board is comprised of FR4 material. The board thickness is 1.66mm and the area is 174mm × 135mm.

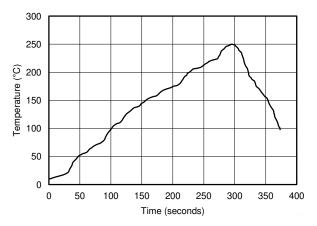


Figure 7-1. Reflow Profile

The reference output voltage is measured before and after the reflow process; Figure 7-2 shows the typical shift. Although all tested units exhibit very low shifts (< 0.03%), higher shifts are also possible depending on the size, thickness, and material of the printed circuit board (PCB). An important note is that the histograms display the typical shift for exposure to a single reflow profile. Exposure to multiple reflows, as is common on PCBs with surface-mount components on both sides, causes additional shifts in the output bias voltage. If the PCB is exposed to multiple reflows, the device must be soldered in the last pass to minimize its exposure to thermal stress.

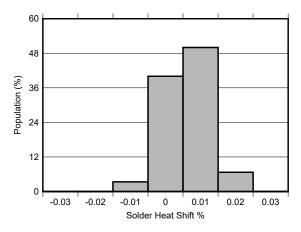


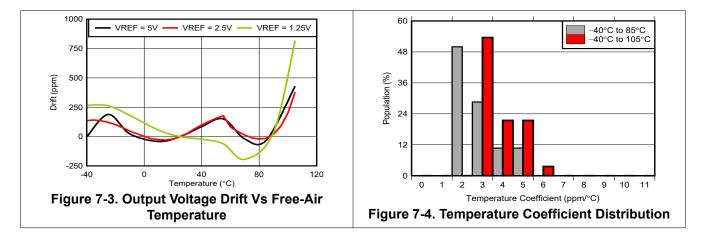
Figure 7-2. Solder Heat Shift Distribution, V_{REF} (%)

7.2 Temperature Coefficient

The REF35 is designed and tested for a low output voltage temperature coefficient. The temperature coefficient is defined as the change in output voltage over temperature. The temperature coefficient is calculated using the box method in which a box is formed by the minimum/maximum values for the nominal output voltage over the operating temperature range. REF35 has a low maximum temperature coefficient of 12ppm/°C from –40°C to +105°C. The box method specifies limits for the temperature error but does not specify the exact shape and slope of the device under test. Due to temperature curvature correction to achieve low-temperature drift, the temperature drift is expected to be non-linear. See Tl's Analog Design Journal, *Precision voltage references*, for more information on the box method. Use Equation 1 for the box method.

$$Drift = \left(\frac{V_{REF(MAX)} - V_{REF(MIN)}}{V_{REF(25^{\circ}C)} \times Temperature \ Range}\right) \times 10^{6}$$
(1)

Figure 7-3 shows a typical voltage versus temperature curves for various reference voltages in SOT23 package. Figure 7-4 shows the distribution of temperature coefficients for REF35250 devices in SOT23 package.



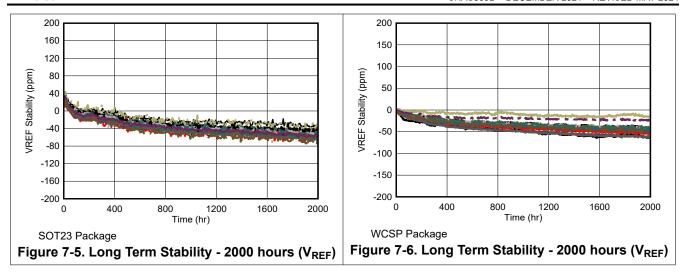
7.3 Long-Term Stability

One of the key performance parameters of the REF35 references is long-term stability also known as long-term drift. The long-term stability value is tested in a setup that reflects standard PCB board manufacturing practices. The boards are made of standard FR4 material and the board does not have special cuts or grooves around the devices to relieve the mechanical stress of the PCB. The devices and boards in this test do not undergo high temperature burn in post-soldering prior to testing. These conditions reflect a real world use case scenario and common manufacturing techniques.

During the long-term stability testing, precautions are taken to make sure that only the long-term stability drift is measured. The boards are maintained at 35°C in an oil bath. The oil bath makes sure that the temperature is constant across the device over time compared to an air oven. The measurements are captured every 30 minutes with a calibrated 8.5 digit multimeter.

The typical long-term stability characteristic is expressed as a deviation of the reference voltage output over time.

Figure 7-5 shows that the typical drift value for the REF35 6-pin SOT-23 package is 40ppm from 0 to 1000 hours and 55ppm from 0 to 2000 hours. It is important to understand that long-term stability is not ensured by design and that the value is typical. The REF35 will experience the highest drift in the initial 1000 hr. Subsequent deviation is typically lower than first 1000 hr.



7.4 Thermal Hysteresis

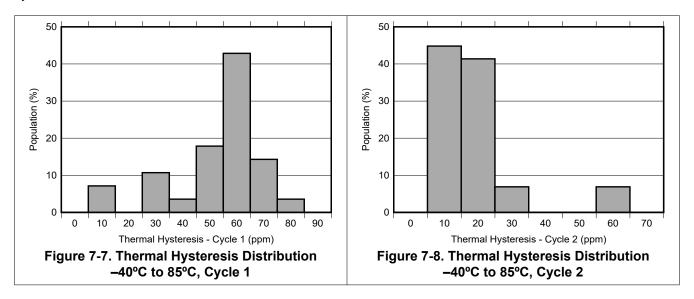
Thermal hysteresis is measured with the REF35 soldered to a PCB, similar to a real-world application. Thermal hysteresis for the device is defined as the change in output voltage after operating the device at 25°C, cycling the device through the specified temperature range, and returning to 25°C. The PCB was baked at 150°C for 30 minutes before thermal hysteresis was measured. Use Equation 2 to calculate the thermal hysteresis:

$$V_{HYST} = \left(\frac{\mid V_{PRE} - V_{POST} \mid}{V_{NOM}}\right) \times 10^{6} \text{ (ppm)}$$
(2)

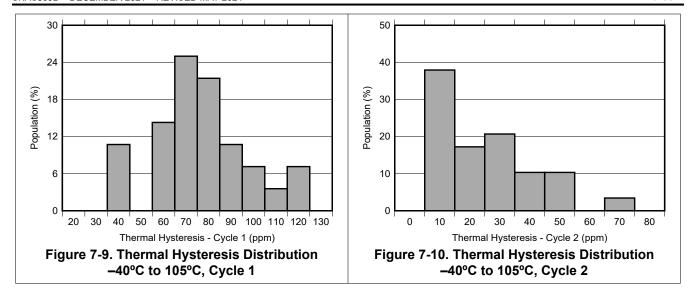
where

- V_{HYST} = thermal hysteresis (in units of ppm)
- V_{NOM} = the specified output voltage
- V_{PRE} = output voltage measured at 25°C pre-temperature cycling
- V_{POST} = output voltage measured after the device has cycled from 25°C through the specified temperature range of -40°C to +85°C or -40°C to +105°C and returns to 25°C.

The graphs below show the typical thermal hysteresis distribution across various temperature ranges in two cycles.







7.5 Noise Performance

The reference pin output noise is categorized as low frequency and broadband noise. The following sections describe these categories in detail.

7.5.1 Low-Frequency (1/f) Noise

Flicker noise, also known as 1/f noise, is a low-frequency noise that affects the device output voltage which can affect precision measurements in ADCs. This noise increases proportionally with output voltage and operating temperature. Noise is measured by filtering the output from 0.1Hz to 10Hz. The 1/f noise is an extremely low value, therefore the frequency of interest must be amplified and band-pass filtered. This is done by using a high-pass filter to block the DC voltage. The resulting noise is then amplified by a gain of 1000. The bandpass filter is created by a series of high-pass and low-pass filter that adds additional gain to make it more visible on a oscilloscope as shown in Figure 7-11. Figure 7-12 shows the effect of flicker noise over 10 second for REF35250. Flicker noise must be tested in a Faraday cage enclosure to block environmental noise.

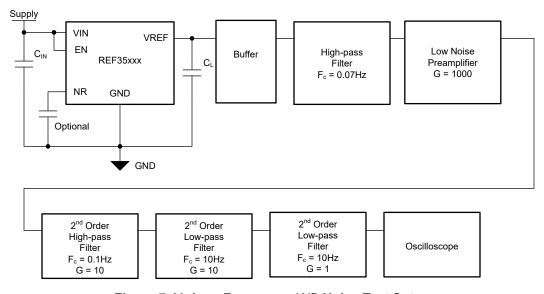


Figure 7-11. Low-Frequency (1/f) Noise Test Setup

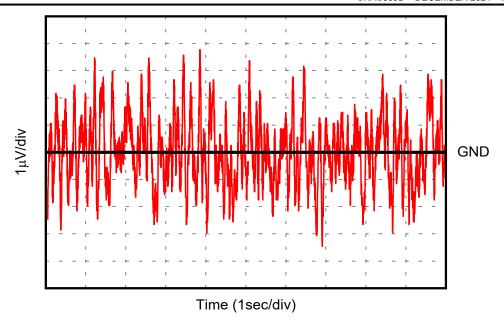
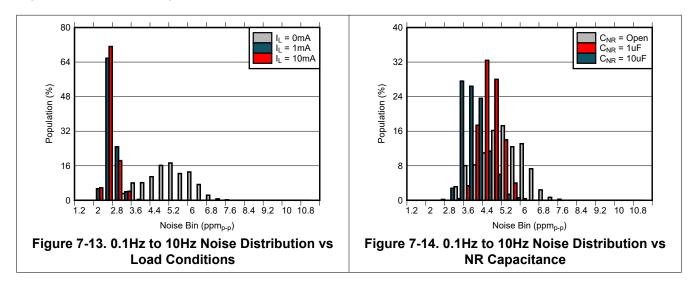


Figure 7-12. 0.1Hz to 10Hz Voltage Noise

Figure 7-13 shows the typical 1/f noise (0.1Hz to 10Hz) distribution across various load conditions. REF35 device also offers noise reduction functionality by adding an optional capacitor between NR (pin 5) and ground pins.

Figure 7-14 shows the typical 1/f noise (0.1Hz to 10Hz) distribution across REF35 devices with various capacitance between NR pin and GND.



7.5.2 Broadband Noise

Broadband noise is a noise that appears at higher frequency compared to 1/f noise. The broadband noise is measured by high-pass filtering the output of the reference device, followed by a gain stage and measuring the result on a spectrum analyzer as shown in Figure 7-15.



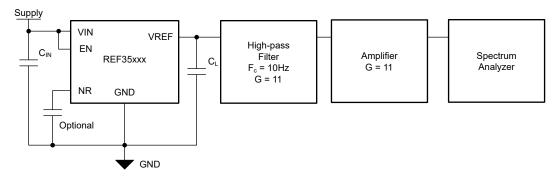
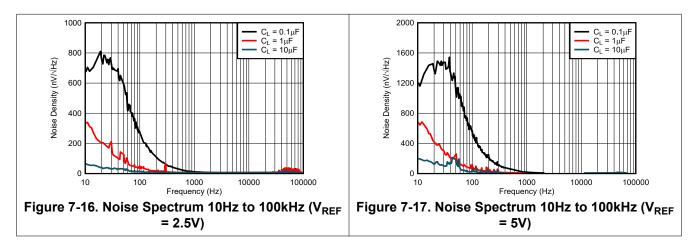


Figure 7-15. Broadband Noise Test Setup

For noise sensitive designs, a low-pass filter can be used to reduce broadband output noise. When designing a low-pass filter, take special care to make sure the output impedance of the filter does not degrade AC performance. This can occur in RC low-pass filters where a large series resistance can impact the load transients due to output current fluctuations. The REF35 device also offers noise reduction functionality by adding an optional capacitor between NR (pin 5) and ground pins. Figure 7-16 and Figure 7-17 show the noise spectrum for REF35250 and REF35500 devices respectively across various load capacitance.



7.6 Power Dissipation

The REF35 voltage references are capable of source up to 10mA and sink up to 5mA of load current across the rated input voltage range. However, when used in applications subject to high ambient temperatures, the input voltage and load current must be carefully monitored to make sure that the device does not exceeded its maximum power dissipation rating. The maximum power dissipation of the device can be calculated with Equation 3:

$$T_{J} = T_{A} + P_{D} \times R_{\theta J A} \tag{3}$$

where

- P_D is the device power dissipation
- T_J is the device junction temperature
- T_A is the ambient temperature
- R_{0JA} is the package (junction-to-air) thermal resistance

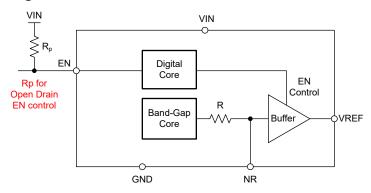
Because of this relationship, acceptable load current in high temperature conditions can be less than the maximum current-sourcing capability of the device. In no case must the device be operated outside of its maximum power rating because doing so can result in premature failure or permanent damage to the device.

8 Detailed Description

8.1 Overview

The REF35 is family of ultra-low current, low-noise, precision band-gap voltage references that are specifically designed for excellent initial voltage accuracy and drift. The *Functional Block Diagram* is a simplified block diagram of the REF35 showing basic band-gap topology.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Supply Voltage

The REF35 family of references features an extremely low dropout voltage. For 10mA loaded conditions, a maximum dropout voltage is 250mV. Figure 6-34 shows a typical dropout voltage (V_{DO}) versus load current. The device supports operation with input voltage range from $V_{REF} + V_{DO}$ to 6V. The typical quiescent current is 650nA and maximum quiescent current over temperature is only 2.6 μ A. The low dropout voltage coupled with ultra-low current enable the operation across multiple battery powered applications.

8.3.2 EN Pin

The REF35 family supports device enable and disable functionality through logic level control on EN pin. The EN pin of REF35 does not use an internal pull-up resistor. Instead, the pin uses new 'clean EN' technology. This allows the EN pin to be in a no connect condition at start-up, and no extra current is drawn from the supply when the EN pin is pulled low in shutdown mode. When EN pin is pulled high or left unconnected at start-up, the device is in active mode. When EN pin is driven by an open-drain output, a pull-up resistor to VIN is required. The device must be in active mode for normal operation. The EN pin must not be pulled higher than VIN supply voltage.

The device can be placed in shutdown mode by pulling the EN pin low. When in shutdown mode, the output of the device becomes high impedance and the quiescent current of the device drops to 100nA at room temperature. When changing the device state from shutdown to active state, make sure the EN pin is not left floating.

Also note that for applications where EN pin is no-connect, total parasitic capacitance on EN pin must be restricted within 30pF.

See the *Electrical Characteristics* table for logic high and logic low voltage levels.

8.3.3 NR Pin

The REF35 pin allows access to the band-gap through the NR pin. Placing a capacitor from the NR pin to GND creates a low-pass filter in combination with the internal resistance of $60~k\Omega$. Leakage of the capacitance directly impacts the accuracy and temperature drift. If NR functionality is used, choose a low leakage capacitor. A capacitance of 1μ F creates a low-pass filter with corner frequency around 2.7Hz. Such a filter decreases the overall noise on the VREF pin. Higher capacitance results in a lower filter cut off frequency, further reducing output noise. Please note, using the capacitor on NR pin also increases start-up time.

8.4 Device Functional Modes

8.4.1 Basic Connections

Figure 8-1 shows the typical connections for the REF35. TI recommends a supply bypass capacitor (C_{IN}) ranging from 0.1μF to 10μF. A 0.1μF to 10μF output capacitor (C_{L}) must be connected from REF to GND. The equivalent series resistance (ESR) value of C_{L} must be lower than $400 \text{m}\Omega$ to verify output stability.

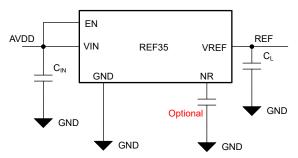


Figure 8-1. Basic Connections

8.4.2 Start-Up

Figure 8-2 shows the start-up behavior of REF35250 device with 1μ F load capacitance. REF35 device verifies the output voltage settles to the expected output voltage within specified accuracy without oscillations. The start-up time is dependent on the output voltage variant, output capacitance and NR pin capacitance. Higher capacitance leads to longer start-up time.

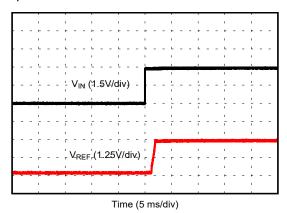


Figure 8-2. REF35250 Start-Up Behavior, $C_L = 1 \mu F$

8.4.3 Output Transient Behavior

The REF35 output buffer is capable of sourcing 10mA load current as well as sink 5mA of load current. The output stage is designed using class AB architecture with ultra-low quiescent current. This architecture avoids the dead zone around the no load condition. The output buffer uses a fast start-up implementation to achieve 2ms typical turn-on time at $C_1 = 1\mu F$ and no-load current condition.

Figure 8-3 and Figure 8-4show the output settling behavior for light load transient and high load transient respectively.

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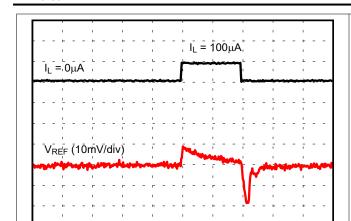


Figure 8-3. Load Transient Response $0\mu A$ to $100\mu A, C_L = 1\mu F$

Time (1ms/div)

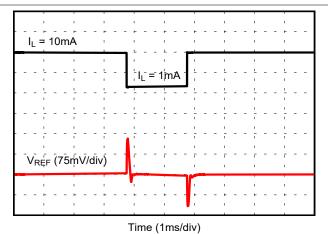


Figure 8-4. Load Transient Response 1mA to 10mA, $C_L = 1 \mu F$

9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

REF35 with low current consumption and class leading performance specifications is suitable reference for multiple applications. The device can also be used as a precision low noise power supply to sensor or data converter instead of traditional LDO or DC/DC based power supply. Basic applications includes positive/negative voltage reference and data acquisition systems. The table below shows the typical application of REF35 and its companion ADC/DAC.

| Table 9-1. Typical Applications and Companion ADC/DAC | | |
|---|------------------------------------|--|
| APPLICATIONS | ADC/DAC | |
| PLC - DCS | ADS7028, DAC8881, ADS1287, ADS7953 | |
| Rack Server | ADS7028, ADS7128, ADS7138 | |
| Field Transmitters - Pressure, Flow | ADS124S08 | |
| Optical Module, Optical Line Card | ADS7066, ADS7138 | |
| Power quality analyzer | ADC3662 | |
| Thermal imaging | ADC3541 | |

Table 9-1. Typical Applications and Companion ADC/DAC

9.2 Typical Applications

9.2.1 Negative Reference Voltage

For applications requiring a negative and positive reference voltage, the REF35 and OPA735 can be used to provide a dual-supply reference from a 5V supply. Figure 9-1 shows the REF35250 used to provide a 2.5V supply reference voltage. The low drift performance of the REF35250 complements the low offset voltage and zero drift of the OPA735 to provide an accurate solution for split-supply applications. Take care to match the temperature coefficients of R1 and R2.

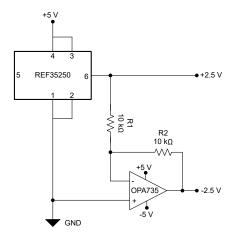


Figure 9-1. REF35 and OPA735 Create Positive and Negative Reference Voltages

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9.2.2 Precision Power Supply and Reference

Figure 9-2 shows the basic configuration for the REF35 device as precision power supply to ADS7038 data converter which uses its power supply AVDD as reference. Connect bypass capacitors according to the guidelines in the *Input and Output Capacitors* section.

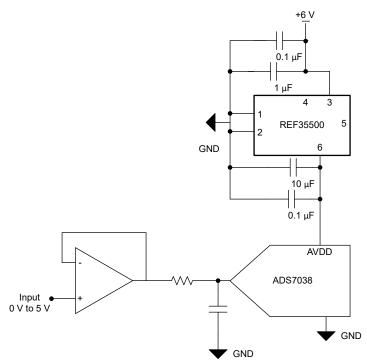


Figure 9-2. Basic Reference Connection

9.2.2.1 Design Requirements

A detailed design procedure is described based on a design example. For this design example, use the parameters listed in Table 9-2 as the input parameters.

 DESIGN PARAMETER
 VALUE

 Input voltage range V_{IN} 0V - 5V

 Output resolution
 12-bit

 REF35 input capacitor
 1 μ F

 REF35 output capacitor
 10 μ F

Table 9-2. Design Example Parameters

9.2.2.2 Detailed Design Procedure

9.2.2.2.1 Selection of Reference

The REF35500 reference is selected for this design. The REF35500 device operates of very low quiescent current while offering ±0.05% initial accuracy and very low noise. These parameters help improve system accuracy as compared to external LDO based power supply. The 5V reference voltage supports the 0V to 5V input range specification.

9.2.2.2.2 Input and Output Capacitors

A $1\mu F$ to $10\mu F$ electrolytic or ceramic capacitor can be connected to the input to improve transient response in applications where the supply voltage may fluctuate.

A ceramic capacitor of at least a $0.1\mu\text{F}$ must be connected to the output to improve stability and help filter out high frequency noise. Add an additional $10\mu\text{F}$ capacitor in parallel to improve transient performance in response to sudden changes in load current; however, keep in mind that doing so increases the start-up time of the device.

Best performance and stability is attained with low-ESR, low-inductance ceramic chip-type output capacitors (X5R, X7R, or similar). If using an electrolytic capacitor on the output, place a 0.1µF ceramic capacitor in parallel to reduce overall ESR on the output. Place the input and output capacitors as close as possible to the device.

9.2.2.2.3 Selection of ADC

ADS7038 12-bit 8 channel multiplexed ADC is chosen for this application. The ADC offers low current operation with averaging mode to increase the resolution to 16-bit with internal averaging modes while operating with slow sampling speed.

9.2.2.3 Application Curves

Table 9-3 and Figure 9-3 show the captured measurement results for various DC inputs. The ADC output is captured and analyzed for output accuracy error and code spread with REF35500 as power supply versus LDO as power supply.

REF35 offers better accuracy and lower noise than the LDO device at lower quiescent current. This results in lower error in measurement as well as lower ADC output code variation across various OSR settings.

REF35500 LDO **INPUT V ADC OSR SETTING ERROR CODE SPREAD ERROR CODE SPREAD** 1.0V 0 0.01mV 32 LSB 8.9mV 48 LSB 8 10 LSB 16 LSB 0.3mV 9.21mV 128 0.38mV 6 LSB 9.26mV 6 LSB 2.5V 0 0.69mV 32 LSB 22.89mV 64 LSB 8 1.44mV 10 LSB 23.63mV 18 LSB 128 1.17mV 3 LSB 23.41mV 5 LSB 4V 0 2.27mV 32 LSB 37.84mV 48 LSB 8 3.01mV 24 LSB 38.62mV 24 LSB 128 2.46mV 3 LSB 38.09mV 17 LSB

Table 9-3. DC Input Performance Test Results

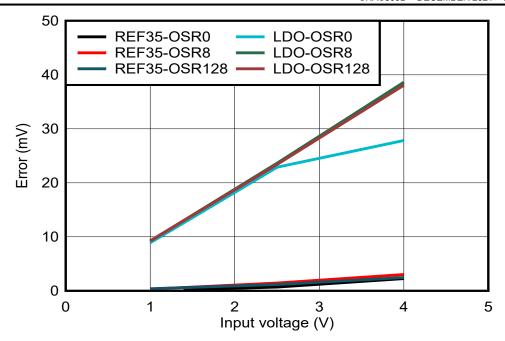


Figure 9-3. Error vs Input Voltage

9.3 Power Supply Recommendations

The REF35 family of references feature an extremely low-dropout voltage. These references can be operated with a supply of only 50mV above the output voltage at no load. TI recommends a supply bypass capacitor ranging between $0.1\mu\text{F}$ to $10\mu\text{F}$.

9.4 Layout

9.4.1 Layout Guidelines

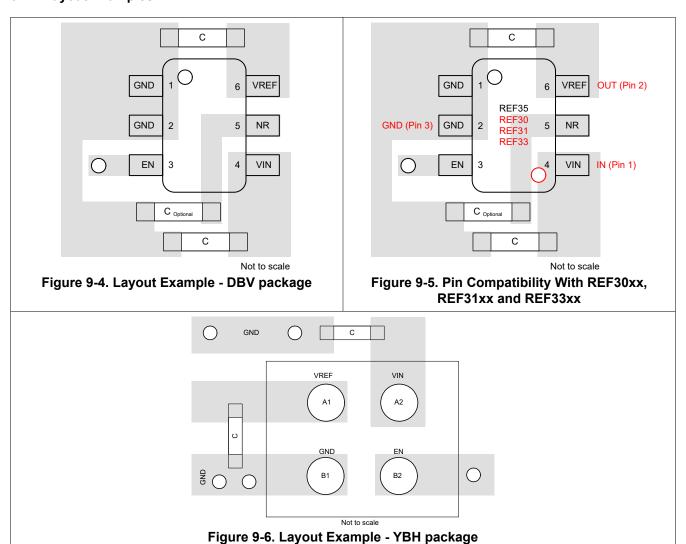
Figure 9-4 shows an example of a PCB layout for a data acquisition system using the REF35. Some key considerations are:

- Connect low-ESR, 0.1µF ceramic bypass capacitors at V_{IN}, V_{REF} of the REF35.
- Decouple other active devices in the system per the device specifications.
- Using a solid ground plane helps distribute heat and reduces electromagnetic interference (EMI) noise pickup.
- · Place the external components as close to the device as possible.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if
 possible, and only make perpendicular crossings when absolutely necessary.

Figure 9-5 shows the pin compatibility with TI REF30xx, REF31xx and REF33xx series references in the 3-pin SOT-23 package when using the REF35xxx family footprint. You must rotate the REF30xx, REF31xx and REF33xx reference devices by 180° before assembly.



9.4.2 Layout Examples



10 Device and Documentation Support

10.1 Documentation Support

10.1.1 Related Documentation

For related documentation see the following:

- Texas Instruments, INA21x Voltage Output, Low- or High-Side Measurement, Bidirectional, Zero-Drift Series, Current-Shunt Monitors data sheet
- Texas Instruments, Low-Drift Bidirectional Single-Supply Low-Side Current Sensing Reference Design
- · Texas Instruments, Precision voltage references Analog Design Journal

10.2 Receiving Notification of Documentation Updates

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

11 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Revision A (August 2022) to Revision B (April 2024) | Page |
|--|------|
| Added features description for WCSP package | 1 |
| Removed product preview status for WCSP package | 1 |
| Added REF35170QBVR & REF35360QDBVR devices as released variant. Updated the WCSP devices | |
| release options | |
| Added more details to device pin external connections | |
| Added YBH package performance details | 6 |
| Added typical characteristics for WCSP package | 8 |
| Changes from Revision * (December 2021) to Revision A (August 2022) | Page |
| Production data release | 1 |



12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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